Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/525,804	VAN LAMMEREN ET AL.	
Examiner	Art Unit	
Olumide T. Ajibade-Akonai	2617	

SEARCHED			
Class	Subclass	Date	Examiner
455	333	11/12/2007	OA
455	558	11/6/2006	OA
716	16	11/6/2006	OA
716	17	11/6/2006	OA
714	55	11/12/2007	OA
711	100	11/6/2006	OA
711	101	11/6/2006	OA
711	102	11/6/2006	OA
711	103	11/6/2006	OA
711	106	11/6/2006	OA
711	149	11/6/2006	OA
711	163	11/6/2006	OA
365	94	11/6/2007	OA
365	185.01	11/6/2007	OA

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Craig Walter and Matt Kim, class/subclass search 711/149,163	11/7/2007	OA
Phallaka Kik; class search 713, 710, 326	11/6/2007	OA
Vibol Tan; class search; 711, 710	11/7/2007	OA
Ilwood Park; class search 717	11/7/2007	OA
Rafael Perez-Gutierrez; class search 711	11/6/2007	OA

Search Notes (continued)



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	SEARCHED		
Class	Subclass	Date	Examiner
365	189.01	11/6/2007	OA
IEEE		11/12/2007	OA
PLUS		11/12/2007	OA
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARCH	STRATEGY	<u>()</u>
	DATE	EXMR
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